#### TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

# TC74VHC157F, TC74VHC157FN, TC74VHC157FT

## QUAD 2-CHANNEL MULTIPLEXER

The TC74VHC157 is an advanced high speed CMOS QUAD 2 - CHANNEL MULTIPLEXER fabricated with silicon gate  $C^2MOS$  technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

It consists of four 2-input digital multiplexers with common select and strobe inputs.

When the STROBE input is held "H" level, selection of data is inhibited and all the outputs become "L" level.

The SELECT decoding determines whether the A or B inputs get routed to their corresponding Y outputs.

An Input protection circuit ensures that 0 to 5.5V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5V to 3Vsystems and on two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

#### FEATURES:

- High Speed------t<sub>pd</sub> = 4.1ns(typ.) at  $V_{CC}$  = 5V
- Low Power Dissipation  $\dots I_{CC} = 4\mu A(Max.)$  at Ta = 25°C
- High Noise Immunity  $V_{\text{NIH}} = V_{\text{NIL}} = 28\% V_{\text{CC}}$  (Min.)
- Power Down Protection is provided on all inputs.
- Balanced Propagation Delays  $\cdots t_{pLH} \simeq t_{pHL}$
- Wide Operating Voltage Range  $\sim V_{CC}$  (opr) = 2V ~ 5.5V
- Pin and Function Compatible with 74ALS157

#### TRUTH TABLE

	INP					
ST	SELECT	А	В	OUTPUT		
Н	X	Х	X	L		
L	L	L	X	L		
L	L	Н	X	Н		
L	н	Х	L	L		
L	Н	Х	Н	Н		
X :	Don't Cai	re				





#### **PIN ASSIGNMENT**



#### IEC LOGIC SYMBOL



980910EBA2

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# TOSHIBA

#### SYSTEM DIAGRAM



980910EBA2'

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# TOSHIBA

## ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage Range	V <sub>cc</sub>	-0.5~7.0	V
DC Input Voltage	VIN	-0.5~7.0	V
DC Output Voltage	V <sub>OUT</sub>	-0.5~V <sub>CC</sub> +0.5	V
Input Diode Current	I <sub>IK</sub>	- 20	mA
Output Diode Current	Ι <sub>οκ</sub>	±20	mA
DC Output Current	I <sub>OUT</sub>	±25	mA
DC V <sub>cc</sub> /Ground Current	I <sub>cc</sub>	± 50	mA
Power Dissipation	P <sub>D</sub>	180	mW
Storage Temperature	T <sub>stg</sub>	-65~150	°C

# **RECOMMENDED OPERATING CONDITIONS**

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage	V <sub>cc</sub>	2.0~5.5	V
Input Voltage	VIN	0~5.5	V
Output Voltage	V <sub>OUT</sub>	0~V <sub>cc</sub>	V
Operating Temperature	T <sub>opr</sub>	-40~85	°
Input Rise and Fall Time	dt/dv	0~100 (V <sub>CC</sub> = 3.3 ± 0.3V) 0~20 (V <sub>CC</sub> = 5±0.5V)	ns / V

## **DC ELECTRICAL CHARACTERISTICS**

PARAMETER	SYMBOL	TEST C		V <sub>cc</sub>	Ta = 25		C	Ta = — 40~85°C		
PARAIVIETER	STIVIBUL	TEST CONDITION		(V)	MIN.	TYP.	MAX.	MIN.	MAX.	
High - Level				2.0	1.50	_	-	1.50	—	
Input Voltage	VIH			3.0~ 5.5	$V_{cc} \times 0.7$	-	_	$V_{cc} \times 0.7$	—	V
Low - Level				2.0		-	0.50	—	0.50	
Input Voltage	V <sub>IL</sub>			3.0~ 5.5	_	_	$V_{cc} \times 0.3$	_	$V_{cc} \times 0.3$	V
	V <sub>OH</sub>		$I_{OH} = -50 \mu A$	2.0	1.9	2.0	-	1.9	—	
High - Level Output Voltage		$V_{1N} =$		3.0 4.5	2.9 4.4	3.0 4.5	_	2.9 4.4	_	v
output voltage		V <sub>IH</sub> or V <sub>IL</sub>	$I_{OH} = -4mA$ $I_{OH} = -8mA$	3.0 4.5	2.58 3.94	-	_	2.48 3.80	-	
	V <sub>OL</sub>			2.0	_	0.0	0.1	—	0.1	
Low - Level Output Voltage		V <sub>IN</sub> =	I <sub>OL</sub> = 50μA	3.0 4.5	_	0.0 0.0	0.1 0.1	_	0.1 0.1	v
output fondge		V <sub>IH</sub> or V <sub>IL</sub>	$I_{OL} = 4mA$ $I_{OL} = 8mA$	3.0 4.5	—	_	0.36 0.36	_	0.44 0.44	
Input Leakage Current	I <sub>IN</sub>	$V_{1N} = 5.5V \text{ or GND}$		0~5.5	_	_	±0.1	_	± 1.0	
Quiescent Supply Current	I <sub>cc</sub>	$V_{1N} = V_{CC} \text{ or } GND$		5.5	_	-	4.0	—	40.0	μA

PARAMETER		TEST	T CONDITION		Ta = 25°C			Ta = − 40~85°C		UNIT
PARAIVIETER	SYMBOL		V <sub>cc</sub> (V)	CL (pF)	MIN.	TYP.	MAX.	MIN.	MAX.	
	t <sub>pLH</sub>		3.3 ± 0.3	15		6.2	9.7	1.0	11.5	
Propagation Delay Time				50	—	8.7	13.2	1.0	15.0	
(A, B-Y)	t <sub>pHL</sub>			15	—	4.1	6.4	1.0	7.5	
			5.0 ± 0.5	50	—	5.6	8.4	1.0	9.5	
Description Data Time			3.3±0.3	15	—	8.4	13.2	1.0	15.5	- ns
Propagation Delay Time	t <sub>pLH</sub> t <sub>pHL</sub>		5.5 ± 0.5	50	—	10.9	16.7	1.0	19.0	
(SELECT - Y)			5.0 ± 0.5	15	—	5.3	8.1	1.0	9.5	
				50	_	6.8	10.1	1.0	11.5	
	t <sub>pLH</sub> t <sub>pHL</sub>	3.3±0.3 5.0±0.5	33+03	15	—	8.7	13.6	1.0	16.0	
Propagation Delay Time			5.5±0.5	50	_	11.2	17.1	1.0	19.5	
( <u>ST</u> - Y )			15	_	5.6	8.6	1.0	10.0		
		5.0 ± 0.		50	-	7.1	10.6	1.0		12.0
Input Capacitance	C <sub>IN</sub>				_	4	10	-	10	nE
Power Dissipation Capacitance C <sub>PI</sub>		(	Note 1)			20	_	_	_	pF

# AC ELECTRICAL CHARACTERISTICS (Input $t_r = t_f = 3ns$ )

Note (1)  $C_{PD}$  is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation:

# $I_{CC (opr.)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC} / 4 (per bit)$ **NOISE CHARACTERISTICS (Input t<sub>r</sub> = t<sub>f</sub> = 3ns)**

PARAMETER	SYMBOL	TEST CONDIT	Ta =	UNIT		
FARAIVIETER	STIVIBUL		V <sub>cc</sub> (V)	TYP.	LIMIT	
Quiet Output Maximum Dynamic V <sub>OL</sub>	V <sub>OLP</sub>	$C_L = 50 pF$	5.0	0.3	0.8	~
Quiet Output Minimum Dynamic V <sub>OL</sub>	V <sub>OLV</sub>	$C_L = 50 pF$	5.0	-0.3	-0.8	<
Minimum High Level Dynamic Input Voltage	V <sub>IHD</sub>	$C_L = 50 pF$	5.0	_	3.5	~
Maximum Low Level Dynamic Input Voltage	V <sub>ILD</sub>	$C_L = 50 pF$	5.0		1.5	v

#### INPUT EQUIVALENT CIRCUIT



## SOP 16PIN (200mil BODY) PACKAGE DIMENSIONS (SOP16-P-300-1.27)

Unit in mm



# SOP 16PIN (150mil BODY) PACKAGE DIMENSIONS (SOL16-P-150-1.27)

#### Unit in mm

(Note) This package is not available in Japan.



